

Notic f References Cited

Application/Control No. 10/051,417	Applicant(s)/Patent Under Reexamination JONES ET AL.		
Examiner	Art Unit		
Kyle M. Riddle	3748	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,402,518	09-1983	Locacius, Robert F.	123/90.38
	В	US-5,098,743	03-1992	Juday, Thomas W.	427/295
	С	US-5,412,024	05-1995	Okada et al.	524/494
	D	US-5,511,518	04-1996	Jain et al.	123/195C
	Е	US-5,883,192	03-1999	Natori et al.	525/211
	F	US-5,957,100	09-1999	Frohwerk et al.	123/90.37
	G	US-6,302,074	10-2001	Bolsover et al.	123/184.21
	Η	US-4,985,523	01-1991	Mochizuki et al.	522/173
	_	US-5,375,569	12-1994	Santella, Joel	123/195C
	7	US-5,636,607	06-1997	Sattler et al.	123/195C
	К	US-6,167,855	01-2001	Mammarella et al.	123/184.21
	L	US-			
	М	US-		,	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	. Ь					
	a					
	R				1	
	S			.,		
	Т			_		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.